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Outline

- Materials in a charging Space environment
 - Facilities
 - Testing
- Arcing on Solar array
 - Secondary arcing test set-up; Flashover measurement
 - ISO: Nedo participation
 - Aging effect
- **ESD Physical model**
- ■Low energy Space data analyse
- Amber sensor

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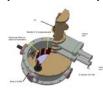
Facilities improvement



• Development of a new sample holder Wih or without PEA measurement

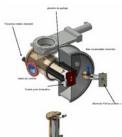


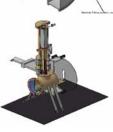
- Development of a sample transfer Unit under vacuum
- Development of a Sample storage Unit under vacuum



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• The objective is to let under vacuum samples for life







Materials in a charging Space environment

- Material tests
 - Long duration relaxation under vacuum
 - Conductivity under realistic charging environment
 - Temperature influence
 - Tests of new material under development
 - PEA (ElectroAcoustic Pulse) measurement

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Arcing on Solar array

- Long distance triggering (influence of the test set-up)
- Flashover measurement on large sample (10 to 12m²)



- Representativity of flashover propagation with plasma tests
- **■** Expertise and standardisation
 - ISO: Nedo participation Aging type C coupon
- Aging effect; extra power loss have been seen on LEO spacecraft, possible ESD aging effect will be studied

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ESD Physical model - Testing

- Secondary emission
 - Adaptation of a MEB for secondary emission measurements.
 CNES/ONERA/INSA-Toulouse study for implementation of in a facility in the CNES quality department
- Optical spectroscopy
 - Objective is to see all the different phases of a discharge, to understand what happens and to learn when short-circuit start (Kapton pyrolise)
- Study of specific geometry
 - Semi grouted gap
 - Over covering coverglass
 - Thermal effect of a discharge

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ESD Physical model - Modelling with SPIS

- Modelling IVGD in a cell gap with SPIS CRIL-ALYOTECH
 - Study of specific geometry taking into account surface conductivity
 - Semi grouted gap

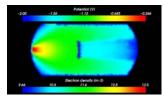


Over covering coverglass



• Modelling vacuum test systematically for better understanding





- French/Japanese cross calibration MUSCAT-SPIS
 - Plasma interaction with a surface, Ram effect

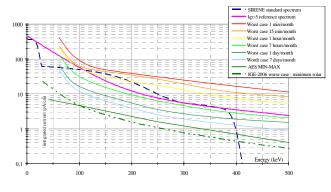
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Low energy Space data analyse

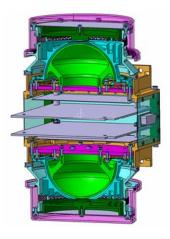
- Analyse LANL data to have worst case environment for 1keV-50keV charging particles
- Worst case are defined 1% of the time, 3% of the time,



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AMBER Sensor



- Analyse and Measurement on Board of Electrostatic Risk
 - Electron and Ion head should be defined this year
 - Budget for a light and low consumption model have been asked for 2008. CDR done.

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SPIS Activities

- Study of the feasibility of SPIS-GEO (ARTENUM 23k).
- **CNES-ESA funding for SPIS**

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Future requirement

- Setup a SPIS licence including install & maintenance (ARTENUM 10k€year)
- Develop and maintain French modelling capability in a little company for space application (CRIL ALYOTECH 20k€year)

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